

566.38683CX1

## IN THE UNITED STATES PATENT AND TRADEMARK OFFICE

Applicants:

Masato YOSHIDA, et al.

Serial No.:

10/042,271

Filed:

January 11, 2002

For:

ABRASIVE METHOD OF POLISHING TARGET MEMBER AND

PROCESS FOR PRODUCING SEMICONDUCTOR DEVICE

Group:

3723

Examiner:

Shantese L. McDonald

## TERMINAL DISCLAIMER

Commissioner for Patents

RECEIVED

May 28, 2004

P.O. Box 1450 Alexandria, VA 22313-1450

JUN 0 7 2004

Sir:

**TECHNOLOGY CENTER R3700** 

Petitioner, Hitachi Chemical Company, Ltd., having its place of business at 1-1, Nishishinjuku 2-chome, Shinjuku-ku, Tokyo, Japan, represents that it is the sole owner of the entire interest of U.S. Application Serial No. 10/042,271, filed January 11, 2002, for ABRASIVE METHOD OF POLISHING TARGET MEMBER AND PROCESS FOR PRODUCING SEMICONDUCTOR DEVICE, and that the Assignment of all rights in connection therewith has been recorded at Reel 011094, Frame 0768.

Petitioner hereby disclaims all that portion of the term of any patent to be issued on the above-identified application subsequent to the expiration date of the full statutory term, defined in 35 U.S.C. 154 to 156 and 173, of U.S. Patent

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